TOSHIBA CMOS DIGITAL INTEGRATED CIRCUIT SILICON MONOLITHIC

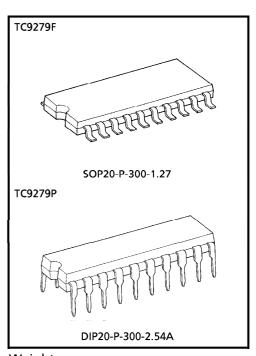
TC9279F, TC9279P

Σ - Δ modulation system da converter with built-in 8 times **OVER SAMPLING DIGITAL FILTER**

The TC9279F and TC9279P are a second-order Σ - Δ modulation system 1-bit DA converter incorporating an 8-times oversampling digital filter, dynamic digital bass boost function for use with compressor operations and an analog filter developed for digital audio equipment. Because the IC is small package (SOP20, DIP20) and includes the digital de-emphasis filter, it is possible to constitute reducing the size and cost of the DA converter.

FEATURES

- Built-in 8-times oversampling digital filter
- Low voltage operations (3.3 V) possible
- Built-in digital de-emphasis filter
- DA converter oversampling ratio (OSR) is 192 fs
- Sampling frequency: 32 kHz, 48 kHz



Weight SOP20-P-300-1.27 : 0.48 g (Typ.)

DIP20-P-300-2.54A : 1.4 g (Typ.)

• Characteristics of the digital filter and DA Converter are as follows:

Digital Filter (fs = 48 kHz)

	Digital	Pass-Band	Transient	Stop-Band
	Filter	Ripple	Band Width	Suppression
Standard Operation	8 fs	± 0.11 dB	21.7 k~25.5 kHz	– 26 dB or less

DA Converter $(V_{DD} = 5.0 \text{ V})$

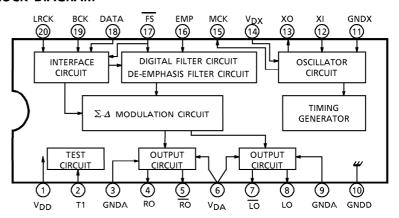
	OSR	Noise Distortion	S/N Ratio
Standard Operation	192 fs	– 90 dB (Typ.)	100 dB (Typ.)

2001-06-19

PIN CONNECTION

TC9279F, TC9279P VDD 1 20 LRCK T1 2 19 BCK GNDA 3 18 DATA RO 4 17 FS RO 5 16 EMP VDA 6 15 MCK LO 7 14 VDX LO 8 13 XO GNDA 9 12 XI GNDD 10 11 GNDX <TOP VIEW>

BLOCK DIAGRAM



PIN FUNCTION

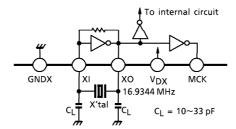
PIN No.	SYMBOL	1/0	FUNCTION & OPERATION	REMARKS
1	V _{DD}	_	Digital block power supply pin	
2	T1	I	Test pin. Normally, use at "L".	
3	GNDA	_	Analog GND pin for DA converter (R-channel)	
4	RO	0	R-channel data forward output pin.	
5	RO	0	R-channel data reverse output pin.	
6	V _{DA}	_	Analog power supply pin for DA converter.	
7	LO	0	L-channel data reverse output pin.	
8	LO	0	L-channel data forward output pin.	
9	GNDA	_	Analog GND pin for DA converter (L-channel)	
10	GNDD	_	Digital GND pin	
11	GNDX	_	Crystal oscillator GND pin	
12	ΧI	I	Crystal oscillator connection pin. Connecting a crystal	
13	ХО	0	oscillator, the system clock (384 fs) is generated.	XI XO
14	V _{DX}	_	Crystal oscillator power supply pin.	
15	MCK	0	System clock output pin (384 fs).	
16	EMP	ı	De-emphasis filter ON / OFF switching pin. ON at "H" and OFF at "L".	
17	FS	ı	Sampling frequency mode selection pin "H" = 32 kHz, "L" = 48 kHz.	
18	DATA	ı	Audio data input pin	
19	BCK	ı	Bit clock input pin	
20	LRCK	I	LR clock input pin	

DESCRIPTION OF BLOCK OPERATION

1. Crystal Oscillation Circuit and Timing Generator

The clock required for internal operations is generated by connecting a crystal and condensers as shown in the diagram below.

The IC will also operate when a system clock is input from an external source through the XI pin (pin 15). However, in this situation, due consideration must be given to the fact that waveform characteristics, such as jitter and rising / falling characteristics of the system clock, significantly affect the DA converter's noise distortion and the S/N ratio.



Use a crystal with a low CI value and favorable start-up characteristics.

Fig.1 Crystal Oscillation Circuit Configuration (when in the 384 fs mode)

The timing generator generates the clocks and process timing signals required for such functions as digital filtering and de-emphasis filtering.

2. Data Input Circuit

DATA and the LRCK are loaded to the LSI internal shift registers on the BCK signal rising edge. It is consequently necessary for the DATA and LRCK signals to be synchronized and input on the BCK signal falling edge as indicated in the timing example below. Also, DATA has been designed so that the 16 bits before the change point of LRCK are regarded as valid data, the data. BCK supports only 32 fs.

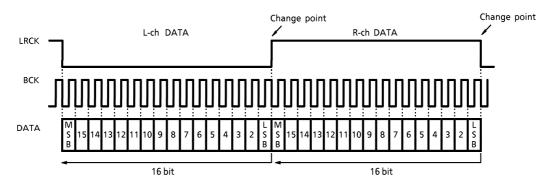


Fig.2 Example of Input Timing Chart

TOSHIBA TC9279F/P

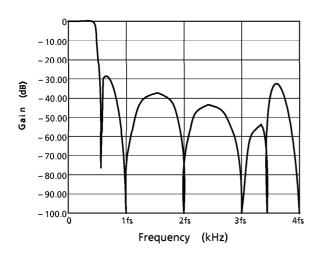
3. Digital Filter

The 8-times oversampling IIR digital filter eliminates the noise returned from outside the bandwidth during standard operations.

Table-1	Basic	Characteristics	of	Digital	Filter
---------	-------	-----------------	----	---------	--------

	Pre-band Ripple	Transient Band Width	Attenuation
Standard Operation	0.011 dB	21.7 k~25.5 kHz	– 26 dB

The characteristics of the digital filter frequencies are shown below.



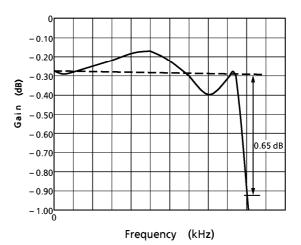


Fig.3 Digial Filter Frequency Characteristics

4. De-emphasis filer

The built-in IIR type de-emphasis filter circuit is available for two kinds of sampling frequency, fs of 32 kHz and 48 kHz.

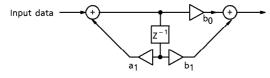
The de-emphasis ON/OFF is controlled by EMP pin, and fs selection is controlled by \overline{FS} pin. Digitization of the de-emphasis filter has eliminated the necessity for external parts such as resistor, capacitor, analog switch, etc.

Further, to reduce the characteristic error of the de-emphasis filter, coefficients have been adjusted. The construction and characteristics of the de-emphasis filter are shown below.

The digitalization of the de-emphasis filter eliminates the need for such external components as resistors, condensers and analog switches. In addition to this, the coefficients are aligned to reduce error in the de-emphasis filter characteristics.

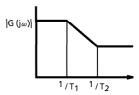
4

The filter structure and characteristics are shown below.



Transfer function : H(Z) = $\frac{(b_0 + b_1 Z^{-1})}{(1 - a_1 Z^{-1})}$

Fig.4 IIR Digital De-emphasis Filter

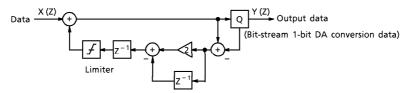


 $T_1 = 50 \mu s$, $T_2 = 15 \mu s$

Fig.5 Filter Characteristics

5. DA Conversion Circuit

The IC incorporates a second-order Σ - Δ modulation DA converter for two channels (simultaneous output type). The internal structure of this is shown in Fig.6.



Second-order Σ - Δ converter : Y(Z) = X(Z) + (1 - Z⁻¹)²Q(Z)

Fig.6. ∑-∆ modulation DA converter

The Σ - Δ modulation clock has been designed to operate at 192 fs. The noise shaping characteristics are shown in Fig.7.

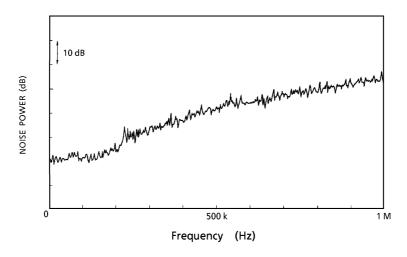


Fig.7 Noise Shaping Characteristics

6. Data Output Circuit

In this circuit, output data waveform is shaped, and forward and reverse signals of bit stream data are output to the outside through a buffer.

By differentiating these forward signal and the reverse signal in the external analog circuit, DA conversion output of low distortion and high S/N ratio can be obtained.

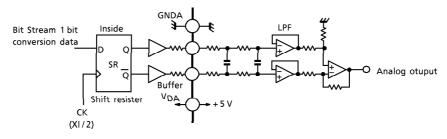


Fig.8 Construction of Data Output Circuit

MAXIMUM RATINGS (Ta = 25°C)

CHARACTERIS	STIC	SYMBOL	RATING	UNIT	
Power Supply Vol	tage	V _{DD} V _{DA}	-0.3~6.0	>	
	·g -	V _{DX}		-	
Input Voltage		V _{in}	$-0.3 \sim V_{DD} + 0.3$	٧	
Dower Dissipation	TC9279F	D _D	200	mW	
Power Dissipation	TC9279P	PD	300	11100	
Operating Temper	ature	T _{opr}	- 35~85	°C	
Storage Temperat	ure	T _{stg}	- 55∼150	°C	

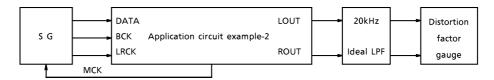
ELECTRICAL CHARACTERISTICS (Unless otherwise specified, Ta = 25° C, $V_{DD} = V_{DX} = V_{DA} = 5 \text{ V}$) DC CHARACTERISTICS

CHARAC	CTERISTIC	SYMBOL	TEST CIR- CUIT	TEST CONDITION	MIN.	TYP.	MAX.	UNIT
Operating Voltage (1		V _{DD} V _{DX} V _{DA}		Ta = −35~85°C	4.5	5	5.5	٧
Opeating Voltage (2		V _{DD} V _{DX} V _{DA}	_	Ta = $-15\sim55^{\circ}$ C (Operation frequency 12 MHz ≤ $f_{opr} \le 18.5 \text{ MHz}$)	3.3	3.5	5.5	>
Power Dis	sipation	lDD		XI = 18.4 MHz	_	12	20	mΑ
Input	"H" Level	VIH	_		$V_{DD} \times 0.7$		V _{DD}	V
Voltage	"L" Level	V _{IL}			0		$V_{DD} \times 0.3$	
Input Current	"H" Level	IH IL	-		- 10	_	10	μΑ

AC CHARACTERISTICS (Oversampling ratio = 192 fs)

Table Harmonic	THD +	1	1 kHz sine wave, full-scale input		- 90	- 80	dB
Distortion + Noise 1	N1	•	$V_{DD} = V_{DX} = V_{DA} = 5 V$		- 30	- 80	ub
Table Harmonic	THD +	1	1 kHz sine wave, full-scale input		- 86	- 78	dB
Distortion + Noise 2	N2	'	$V_{DD} = V_{DX} = V_{DA} = 3.5 V$		- 80	- 70	ub
S/N Ratio	S/N	1		90	100	_	dB
Dynamic Range	DR	1	1 kHz sine wave	90	95		dB
Dynamic Range DK		•	- 60 dB input conversion	30	93		ub
Cross-talk	СТ	1	1 kHz sine wave		- 95	- 90	dB
C1033-talk	Ci	'	full-scale input		- 93	- 90	Ц
Operating Frequency	f _{opr}		$V_{DD} = V_{DA} = V_{DX} \ge 4.5 V$	12	1	18.5	MHz
Input Frequency	f _{LR}		LRCK duty cycle = 50%	30	48	_	kHz
Imput Frequency	requency f _{BCK} -		LNCK duty cycle = 50%	1.0	1.536	_	MHz
Rise Time	t _r		LBCK BCK (100/ - 000/)	_		15	
Fall Time	t _f		LRCK, BCK (10%~90%)	_		15	ns
Delay Time	^t d	_	BCK Edge → LRCK, DATA	_	_	40	ns

• Test circuit 1: With the use of an application circuit example 2



SG: Anritsu: MG-22A or equivalent

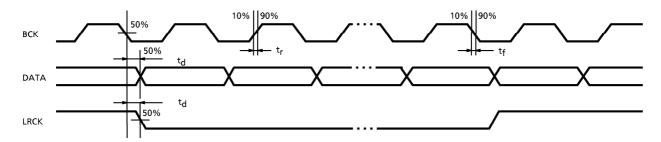
LPF : Shibasoku : Built-in 725C distortion factor gauge filter

Distortion: Shibasoku: 725C or equivalent

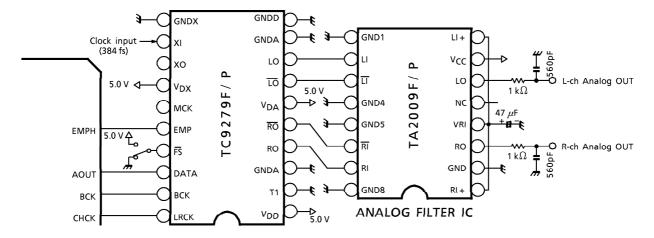
PARAMETER MEASURED	DISTORTION FACTOR GAUGE FILTER SETTING A WEIGHT		
THD + N, CT	OFF		
S/N, DR	ON		

A weight : IEC-A or equivalent

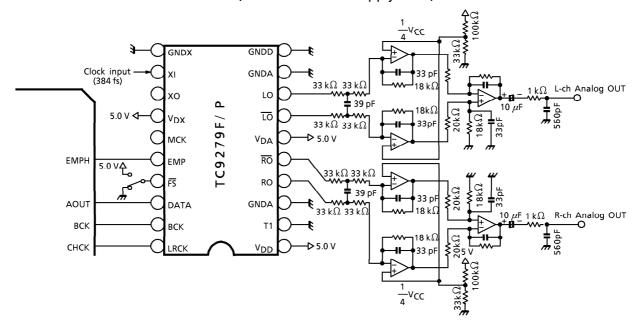
• AC Characteristics Stipulated Point (Input signal stipulation: LRCK, BCK, DATA)



APPLICATION CIRCUIT EXAMPLE-1 (+5 V Single Power Supply Used)



APPLICATION CIRCUIT EXAMPLE-2 (±5V Two Power Supply Used)



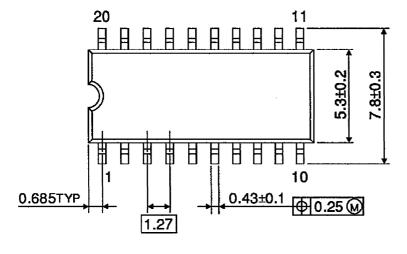
(Cautions)

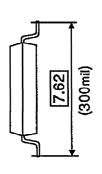
- Quality of crystal oscillation waveform largely affect S/N ratio and noise distortion.
 Further, this is also true when system clock is input externally through the XI pin of pin 12.
- Suppress the input signals grige (LRCK, BCK, DATA) as small as possible.
- The wiring between the output pin of the TC9279F/P and the input pin of analog filter amplifier must be wired as short as possible.
- The condencer between V_{DA} and GNDA shall be connected as close to the pin as possible.

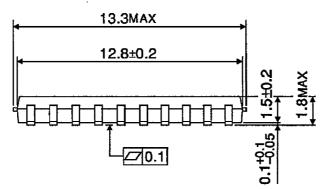
PACKAGE DIMENSIONS

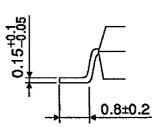
SOP20-P-300-1.27

Unit: mm



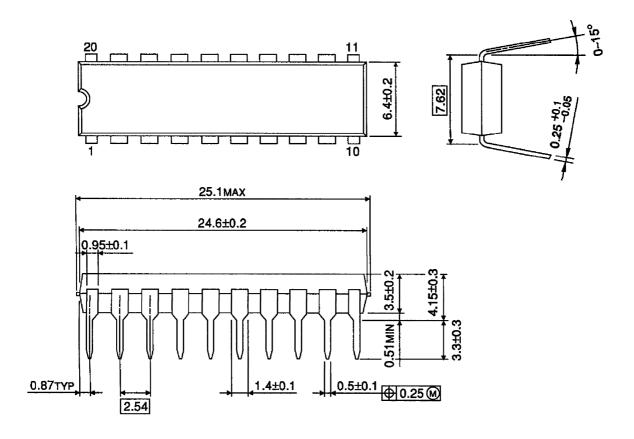






Weight: 0.48 g (Typ.)

PACKAGE DIMENSIONS



Weight: 1.4 g (Typ.)

RESTRICTIONS ON PRODUCT USE

000707EBA

- TOSHIBA is continually working to improve the quality and reliability of its products. Nevertheless, semiconductor devices in general can malfunction or fail due to their inherent electrical sensitivity and vulnerability to physical stress. It is the responsibility of the buyer, when utilizing TOSHIBA products, to comply with the standards of safety in making a safe design for the entire system, and to avoid situations in which a malfunction or failure of such TOSHIBA products could cause loss of human life, bodily injury or damage to property. In developing your designs, please ensure that TOSHIBA products are used within specified operating ranges as set forth in the most recent TOSHIBA products specifications. Also, please keep in mind the precautions and conditions set forth in the "Handling Guide for Semiconductor Devices," or "TOSHIBA Semiconductor Reliability Handbook" etc..
- The TOSHIBA products listed in this document are intended for usage in general electronics applications (computer, personal equipment, office equipment, measuring equipment, industrial robotics, domestic appliances, etc.). These TOSHIBA products are neither intended nor warranted for usage in equipment that requires extraordinarily high quality and/or reliability or a malfunction or failure of which may cause loss of human life or bodily injury ("Unintended Usage"). Unintended Usage include atomic energy control instruments, airplane or spaceship instruments, transportation instruments, traffic signal instruments, combustion control instruments, medical instruments, all types of safety devices, etc.. Unintended Usage of TOSHIBA products listed in this document shall be made at the customer's own risk.
- The products described in this document are subject to the foreign exchange and foreign trade laws.
- The information contained herein is presented only as a guide for the applications of our products. No responsibility is assumed by TOSHIBA CORPORATION for any infringements of intellectual property or other rights of the third parties which may result from its use. No license is granted by implication or otherwise under any intellectual property or other rights of TOSHIBA CORPORATION or others.
- The information contained herein is subject to change without notice.